

BUL1203EFP

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- FULLY INSULATED PACKAGE (U.L. COMPLIANT) FOR EASY MOUNTING

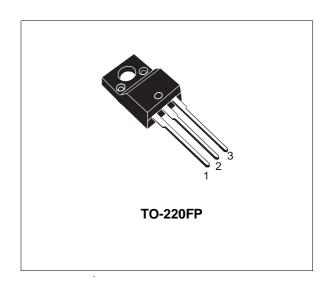
APPLICATIONS

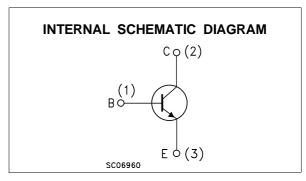
■ ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING (277 V HALF BRIDGE AND 120 V PUSH-PULL TOPOLOGIES)

DESCRIPTION

The BUL1203EFP is a new device manufactured using Diffused Collector technology to enhance switching speeds and tight hFE range while maintaining a wide RBSOA.

Thanks to his structure it has an intrinsic ruggedness which enables the transistor to withstand a high collector current level during Breakdown condition, without using the transil protection usually necessary in typical converters for lamp ballast.





ABSOLUTE MAXIMUM RATINGS

| Symbol | Parameter | Value | Unit | |
|-------------------|---|------------|------|--|
| V_{CBO} | Collector-BaseVoltage (I _E = 0) | 1200 | V | |
| V _{CES} | Collector-Emitter Voltage (V _{BE} = 0) 1200 | | V | |
| V_{CEO} | Collector-Emitter Voltage (I _B = 0) | 550 | V | |
| V _{EBO} | Emitter-Base Voltage (I _C = 0) | 9 | V | |
| Ic | Collector Current | 5 | Α | |
| I _{CM} | Collector Peak Current (t _p < 5 ms) | 8 | Α | |
| I_{B} | Base Current | 2 | Α | |
| I_{BM} | Base Peak Current (t _p < 5 ms) | 4 | Α | |
| P _{tot} | Total Dissipation at T _c = 25 °C | 36 | W | |
| V _{isol} | Insulation Withstand Voltage (RMS) from All Three Leads to Exernal Heatsink | 1500 | V | |
| T_{stg} | Storage Temperature | -65 to 150 | °C | |
| Tj | Max. Operating Junction Temperature | 150 | °C | |

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THERMAL DATA

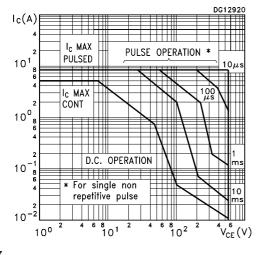
| R _{thj-case} | Thermal Resistance Junction-case | Max | 3.47 | °C/W |
|-----------------------|-------------------------------------|-----|------|------|
| R _{thj-amb} | Thermal Resistance Junction-ambient | Max | 62.5 | °C/W |

ELECTRICAL CHARACTERISTICS ($T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

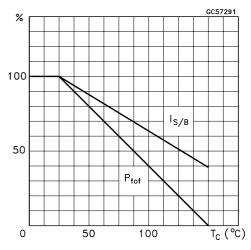
| Symbol | Parameter | Test | Conditions | Min. | Тур. | Max. | Unit |
|---|---|---|--|---------------------|------------|-------------------|----------------|
| I _{CES} | Collector Cut-off Current (V _{BE} = 0) | V _{CE} = 1200 V | | | | 100 | μΑ |
| I _{CEO} | Collector Cut-off Current (I _B = 0) | V _{CE} = 550 V | | | | 100 | μΑ |
| V _{CEO(sus)} * | Collector-Emitter Sustaining Voltage (I _B = 0) | I _C = 100 mA | L = 25 mH | 550 | | | V |
| V_{EBO} | Emitter-Base Voltage (I _C = 0) | I _E = 10 mA | | 9 | | | V |
| V _{CE(sat)} * | Collector-Emitter Saturation Voltage | I _C = 1 A I _C = 2 A I _C = 3 A | I _B = 0.2 A I _B = 0.4 A I _B = 1 A | | | 0.5 0.7 1.5 | V V V |
| V _{BE(sat)} * | Base-Emitter Saturation Voltage | I _C = 2 A I _C = 3 A | I _B = 0.4 A I _B = 1 A | | | 1.5 1.5 | V |
| h _{FE} * | DC Current Gain | I _C = 1 mA I _C = 10 mA I _C = 0.8 A I _C = 2 A | ~- | 10 10 14 9 | | 32 28 | |
| t _{on} t _s t _f | RESISTIVE LOAD Turn-on Time Storage Time Fall Time | I _C = 2 A I _{B2} = -0.8 A V _{CC} = 150 V | $I_{B1} = 0.4 \text{ A}$ $tp = 30 \mu s$ (see figure 2) | | 2.5 0.2 | 0.5 3.0 0.3 | μs μs μs |
| Ear | Repetitive Avalanche Energy | $L = 2 \text{ mH}$ $V_{CC} = 50 \text{ V}$ (see figure 3) | C = 1.8 nF V _{BE} = -5 V | 6 | | | mJ |

^{*} Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

Safe Operating Area



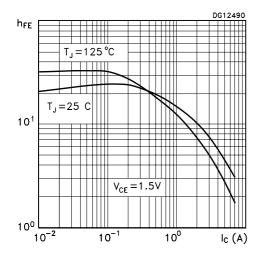
Derating Curve



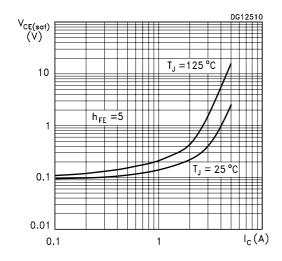
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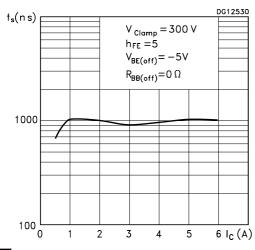
DC Current Gain



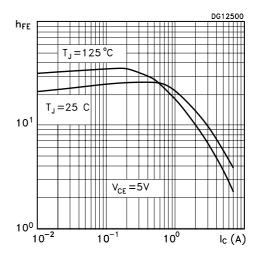
Collector-Emitter Saturation Voltage



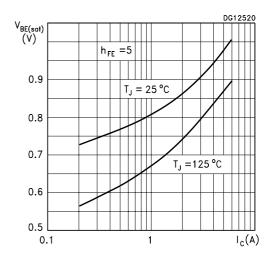
Inductive Load Storage Time



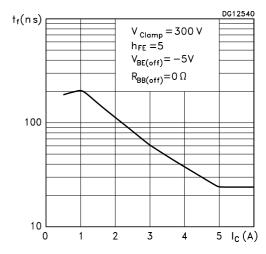
DC Current Gain



Base-Emitter Saturation Voltage



Inductive Load Fall Time



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Reverse Biased Safe Operating Area

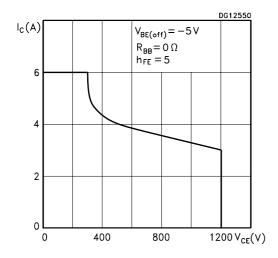


Figure 1: Inductive Load Switching Test Circuit

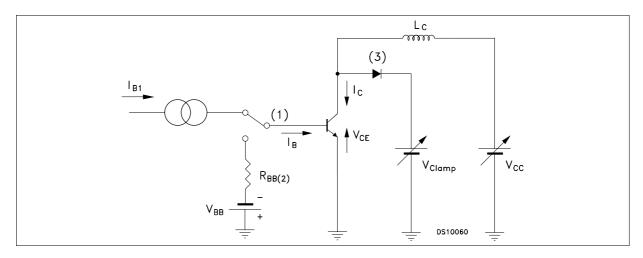
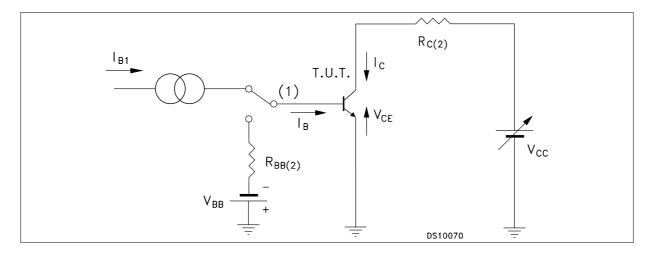
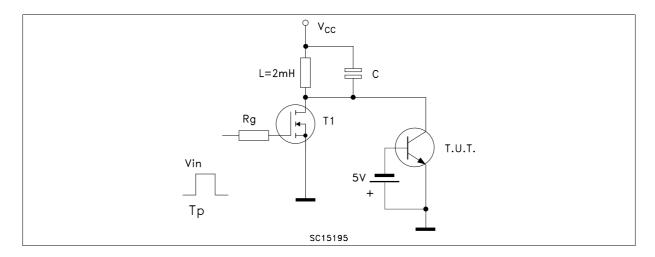


Figure 2: Resistive Load Switching Test Circuit



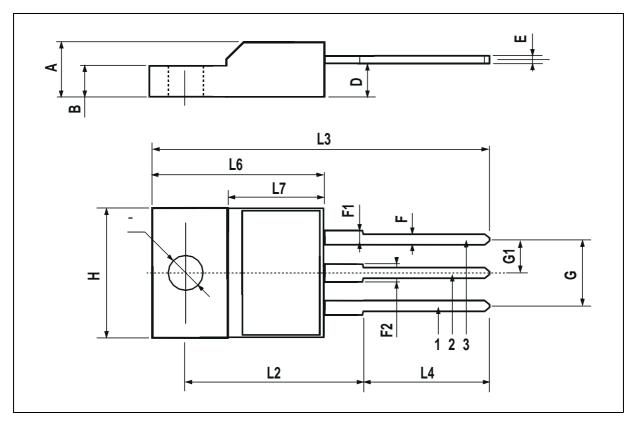
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Figure 3: Energy Rating Test Circuit



TO-220FP MECHANICAL DATA

| DIM. | mm | | | inch | | | |
|-------|------|------|------|-------|-------|-------|--|
| DINI. | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. | |
| А | 4.4 | | 4.6 | 0.173 | | 0.181 | |
| В | 2.5 | | 2.7 | 0.098 | | 0.106 | |
| D | 2.5 | | 2.75 | 0.098 | | 0.108 | |
| Е | 0.45 | | 0.7 | 0.017 | | 0.027 | |
| F | 0.75 | | 1 | 0.030 | | 0.039 | |
| F1 | 1.15 | | 1.7 | 0.045 | | 0.067 | |
| F2 | 1.15 | | 1.7 | 0.045 | | 0.067 | |
| G | 4.95 | | 5.2 | 0.195 | | 0.204 | |
| G1 | 2.4 | | 2.7 | 0.094 | | 0.106 | |
| Н | 10 | | 10.4 | 0.393 | | 0.409 | |
| L2 | | 16 | | | 0.630 | | |
| L3 | 28.6 | | 30.6 | 1.126 | | 1.204 | |
| L4 | 9.8 | | 10.6 | 0.385 | | 0.417 | |
| L6 | 15.9 | | 16.4 | 0.626 | | 0.645 | |
| L7 | 9 | | 9.3 | 0.354 | | 0.366 | |
| Ø | 3 | | 3.2 | 0.118 | | 0.126 | |



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